

DESCRIPTION

The H11GX series are photodarlington-type optically coupled optocouplers. These devices have a gallium arsenide infrared emitting diode coupled with a silicon darlington connected phototransistor which has an integral base-emitter resistor to optimize elevated temperature characteristics.

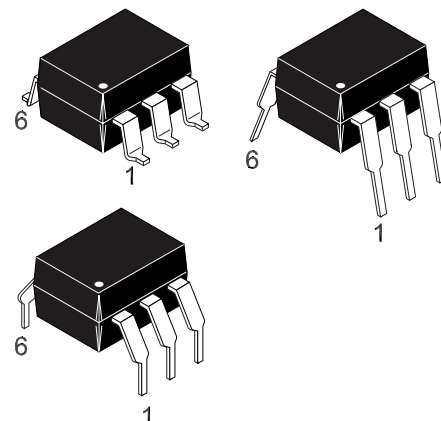
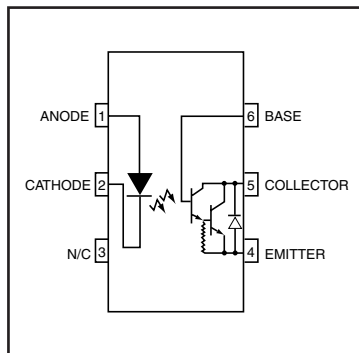
**H11G1
H11G2
H11G3**

FEATURES

- High BV_{CEO}
 - Minimum 100 V for H11G1
 - Minimum 80 V for H11G2
 - Minimum 55 V for H11G3
- High sensitivity to low input current
 - Minimum 500 percent CTR at $I_F = 1$ mA
- Low leakage current at elevated temperature
 - (maximum 100 μ A at 80°C)
- Underwriters Laboratory (UL) recognized File# E90700

APPLICATIONS

- CMOS logic interface
- Telephone ring detector
- Low input TTL interface
- Power supply isolation
- Replace pulse transformer



NOTE

All dimensions are in inches (millimeters)

ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Value	Units
TOTAL DEVICE			
Storage Temperature	T _{STG}	-55 to +150	°C
Operating Temperature	T _{OPR}	-55 to +100	°C
Lead Solder Temperature	T _{SOL}	260 for 10 sec	°C
Total Device Power Dissipation @ T _A = 25°C	P _D	260	mW
Derate above 25°C		3.5	mW/°C
Input-Output Isolation Voltage	V _{ISO}	5300	Vac(rms)
EMITTER			
Forward Input Current	I _F	60	mA
Reverse Input Voltage	V _R	6.0	V
Forward Current - Peak (1μs pulse, 300pps)	I _{F(pk)}	3.0	A
LED Power Dissipation @ T _A = 25°C	P _D	100	mW
Derate above 25°C		1.8	mW/°C
DETECTOR			
Collector-Emitter Voltage	V _{CEO}	100	V
H11G1			
H11G2			
H11G3			
Detector Power Dissipation @ T _A = 25°C	P _D	200	mW
Derate above 25°C		2.67	mW/°C

H11G1, H11G2, H11G3

ELECTRICAL CHARACTERISTICS (T_A = 25°C Unless otherwise specified.)

INDIVIDUAL COMPONENT CHARACTERISTICS

Characteristic	Test Conditions	Symbol	Device	Min	Typ**	Max	Unit
EMITTER							
Forward Voltage	(I _F = 10 mA)	V _F	ALL		1.3	1.50	V
Forward Voltage Temp. Coefficient		$\frac{\Delta V_F}{\Delta T_A}$	ALL		-1.8		mV/°C
Reverse Breakdown Voltage	(I _R = 10 µA)	BV _R	ALL	3.0	25		V
Junction Capacitance	(V _F = 0 V, f = 1 MHz)	C _J	ALL		50		pF
	(V _F = 1 V, f = 1 MHz)		ALL		65		pF
Reverse Leakage Current	(V _R = 3.0 V)	I _R	ALL		0.001	10	µA
DETECTOR							
Breakdown Voltage Collector to Emitter	(I _C = 1.0 mA, I _F = 0)	BV _{CEO}	H11G1	100			V
			H11G2	80			
			H11G3	55			
Collector to Base	(I _C = 100 µA)	BV _{CBO}	H11G1	100			
			H11G2	80			
			H11G3	55			
Emitter to Base		BV _{EBO}	ALL	7	10		
Leakage Current Collector to Emitter	(V _{CE} = 80 V, I _F = 0)	I _{CEO}	H11G1			100	nA
	(V _{CE} = 60 V, I _F = 0)		H11G2				
	(V _{CE} = 30 V, I _F = 0)		H11G3				
	(V _{CE} = 80 V, I _F = 0, T _A = 80°C)		H11G1			100	µA
	(V _{CE} = 60 V, I _F = 0, T _A = 80°C)		H11G2				

TRANSFER CHARACTERISTICS

DC Characteristic	Test Conditions	Symbol	Device	Min	Typ**	Max	Unit
EMITTER							
Current Transfer Ratio Collector to Emitter	(I _F = 10 mA, V _{CE} = 1 V)	CTR	H11G1/2	100 (1000)			mA (%)
	(I _F = 1 mA, V _{CE} = 5 V)		H11G1/2	5 (500)			
			H11G3	2 (200)			
Saturation Voltage	(I _F = 16 mA, I _C = 50 mA)	V _{CE (SAT)}	H11G1/2		0.85	1.0	V
	(I _F = 1 mA, I _C = 1 mA)		H11G1/2		0.75	1.0	
	(I _F = 20 mA, I _C = 50 mA)		H11G3		0.85	1.2	

TRANSFER CHARACTERISTICS

Characteristic	Test Conditions	Symbol	Device	Min	Typ**	Max	Unit
SWITCHING TIMES							
Turn-on Time	(R _L = 100 Ω, I _F = 10 mA)	t _{on}	ALL		5		µs
Turn-off Time	(V _{CE} = 5 V) Pulse Width ≤ 300 µs, f ≤ 30 Hz)	t _{off}	ALL		100		

** All typical values at T_A = 25°C

Fig. 1 Output Current vs. Input Current

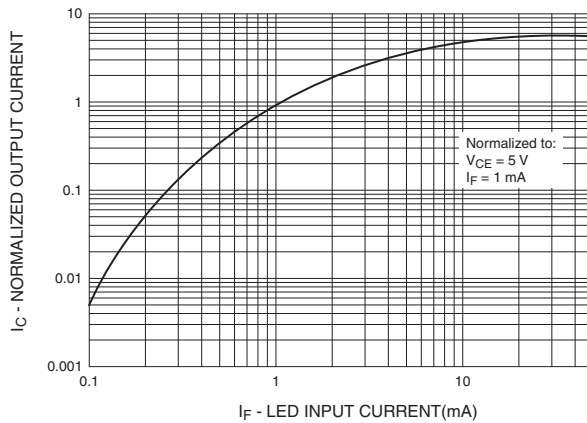


Fig. 2 Normalized Output Current vs. Temperature

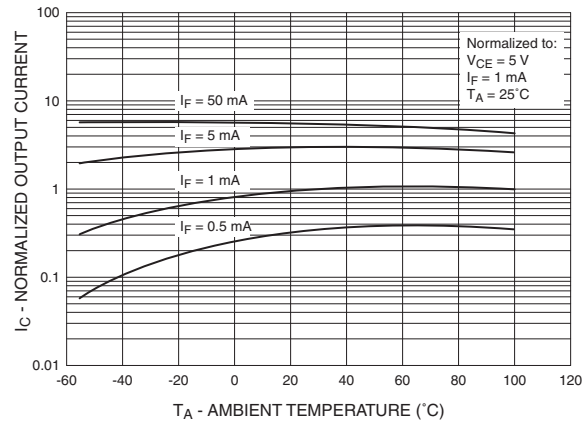


Fig. 3 Output Current vs. Collector - Emitter Voltage

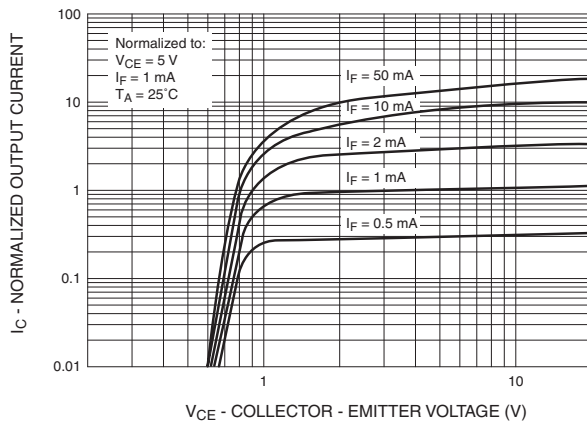


Fig. 4 Collector-Emitter Dark Current vs. Ambient Temperature

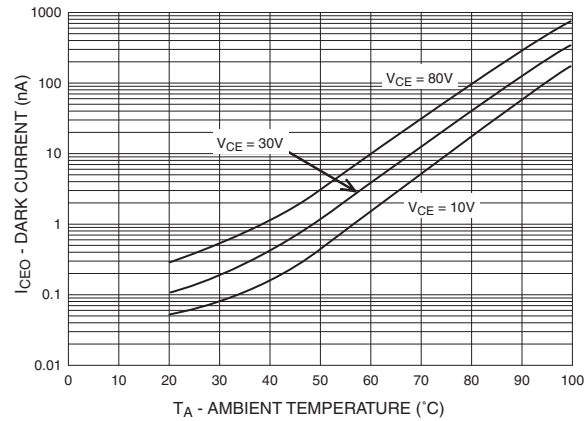
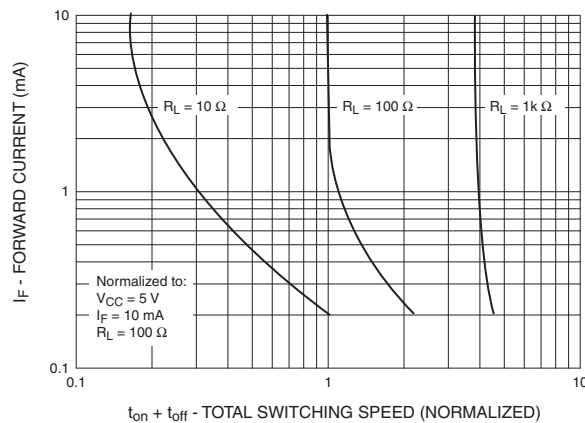
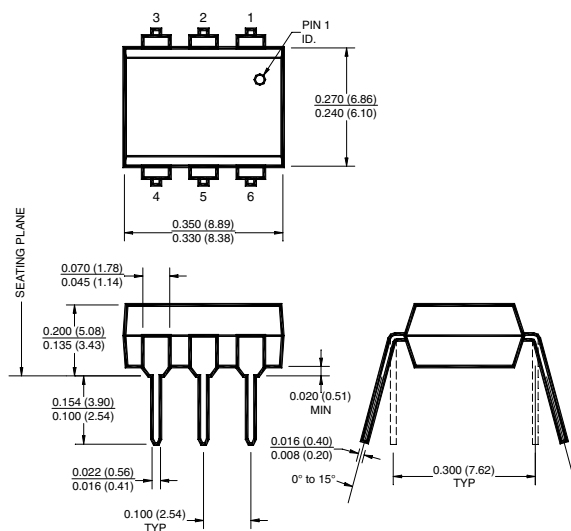


Fig. 5 Input Current vs. Total Switching Speed (Typical Values)



Package Dimensions (Through Hole)



The image displays three mechanical drawings of the 240-00000-00000 component:

- Top View:** Shows a rectangular component with six pins labeled 1 through 6. Pin 1 is located at the top right corner. Dimensions include a top width of 0.350 (8.89) / 0.330 (8.38) and a right height of 0.270 (6.86) / 0.240 (6.10).
- Side View:** Shows the component's profile with a total width of 0.200 (5.08) / 0.165 (4.18) and a bottom thickness of 0.022 (0.56) / 0.016 (0.41).
- Cross-sectional View:** Shows the internal structure with a top width of 0.300 (7.62) TYP, a central width of 0.315 (8.00) MIN, and a total width of 0.405 (10.30) MAX. The bottom thickness is 0.016 (0.41) / 0.008 (0.20).

Additional dimensions for the side and cross-sectional views include 0.070 (1.78) / 0.045 (1.14) for the top width, 0.020 (0.51) MIN for the bottom thickness, and 0.100 (2.54) TYP for the bottom width.

Lead Coplanarity : 0.004 (0.10) MAX

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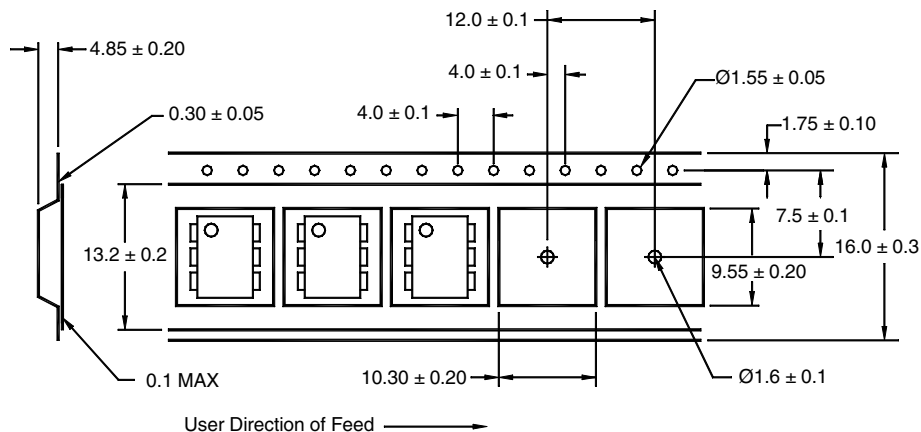
All dimensions are in inches (millimeters)

H11G1, H11G2, H11G3

ORDERING INFORMATION

Option	Order Entry Identifier	Description
S	.S	Surface Mount Lead Bend
SD	.SD	Surface Mount; Tape and reel
W	.W	0.4" Lead Spacing
300	.300	VDE 0884
300W	.300W	VDE 0884, 0.4" Lead Spacing
3S	.3S	VDE 0884, Surface Mount
3SD	.3SD	VDE 0884, Surface Mount, Tape & Reel

QT Carrier Tape Specifications ("D" Taping Orientation)



NOTE

All dimensions are in millimeters

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